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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

E·XFl

2 0 0 0 0 0	
Product Status	Active
Core Processor	RL78
Core Size	16-Bit
Speed	32MHz
Connectivity	CSI, I ² C, LINbus, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	64
Program Memory Size	384KB (384K x 8)
Program Memory Type	FLASH
EEPROM Size	8K x 8
RAM Size	32K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 5.5V
Data Converters	A/D 17x8/10b; D/A 2x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	80-LQFP
Supplier Device Package	80-LQFP (12x12)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f104mkafb-30

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

○ ROM, RAM capacities

Flash ROM	Data flash	RAM	RL78/G14					
TIASH NOW	Data liasii	r\Alvi	30 pins	32 pins	36 pins	40 pins		
192 KB	8 KB	20 KB	—	—	—	R5F104EH		
128 KB	8 KB	16 KB	R5F104AG	R5F104BG	R5F104CG	R5F104EG		
96 KB	8 KB	12 KB	R5F104AF	R5F104BF	R5F104CF	R5F104EF		
64 KB	4 KB	5.5 KB Note	R5F104AE	R5F104BE	R5F104CE	R5F104EE		
48 KB	4 KB	5.5 KB Note	R5F104AD	R5F104BD	R5F104CD	R5F104ED		
32 KB	4 KB	4 KB	R5F104AC	R5F104BC	R5F104CC	R5F104EC		
16 KB	4 KB	2.5 KB	R5F104AA	R5F104BA	R5F104CA	R5F104EA		

Flash ROM	Data flash	RAM		RL78	3/G14	
T IdSIT KOW	Data liasii		44 pins	48 pins	52 pins	64 pins
512 KB	8 KB	48 KB Note	_	R5F104GL	—	R5F104LL
384 KB	8 KB	32 KB	_	R5F104GK	—	R5F104LK
256 KB	8 KB	24 KB Note	R5F104FJ	R5F104GJ	R5F104JJ	R5F104LJ
192 KB	8 KB	20 KB	R5F104FH	R5F104GH	R5F104JH	R5F104LH
128 KB	8 KB	16 KB	R5F104FG	R5F104GG	R5F104JG	R5F104LG
96 KB	8 KB	12 KB	R5F104FF	R5F104GF	R5F104JF	R5F104LF
64 KB	4 KB	5.5 KB Note	R5F104FE	R5F104GE	R5F104JE	R5F104LE
48 KB	4 KB	5.5 KB Note	R5F104FD	R5F104GD	R5F104JD	R5F104LD
32 KB	4 KB	4 KB	R5F104FC	R5F104GC	R5F104JC	R5F104LC
16 KB	4 KB	2.5 KB	R5F104FA	R5F104GA	_	_

Flash ROM	Data flash	RAM	RL78	3/G14
FIDSII ROIVI	Dala liash	RAIN	80 pins	100 pins
512 KB	8 KB	48 KB Note	R5F104ML	R5F104PL
384 KB	8 KB	32 KB	R5F104MK	R5F104PK
256 KB	8 KB	24 KB Note	R5F104MJ	R5F104PJ
192 KB	8 KB	20 KB	R5F104MH	R5F104PH
128 KB	8 KB	16 KB	R5F104MG	R5F104PG
96 KB	8 KB	12 KB	R5F104MF	R5F104PF

The flash library uses RAM in self-programming and rewriting of the data flash memory.

The target products and start address of the RAM areas used by the flash library are shown below.

R5F104xD (x = A to C, E to G, J, L): Start address FE900H

R5F104xE (x = A to C, E to G, J, L): Start address FE900H

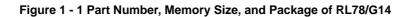
R5F104xJ (x = F, G, J, L, M, P): Start address F9F00H

R5F104xL (x = G, L, M, P): Start address F3F00H

For the RAM areas used by the flash library, see Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944).



1.2 Ordering Information



Part No. R5F104LEAxxxFB#V0 Packaging specification #30: Tray (LFQFP, LQFP) #U0: Tray (HWQFN, WFLGA, FLGA) #V0: Tray (LFQFP, LQFP, LSSOP) #50: Embossed Tape (LFQFP, LQFP) #W0:Embossed Tape (HWQFN, WFLGA, FLGA) #X0: Embossed Tape (LFQFP, LQFP, LSSOP) Package type: SP: LSSOP, 0.65 mm pitch FP: LQFP, 0.80 mm pitch FA: LQFP, 0.65 mm pitch FB: LFQFP, 0.50 mm pitch NA: HWQFN, 0.50 mm pitch LA: WFLGA, 0.50 mm pitch FLGA, 0.50 mm pitch ROM number (Omitted with blank products) Fields of application: A: Consumer applications, TA = -40 to +85 °C D: Industrial applications, TA = -40 to +85 $^{\circ}$ C G: Industrial applications, TA = -40 to +105 °C ROM capacity: A: 16 KB C: 32 KB D: 48 KB E: 64 KB F: 96 KB G: 128 KB H: 192 KB J: 256 KB K: 384 KB L: 512 KB Pin count: A: 30-pin B: 32-pin C: 36-pin E: 40-pin F: 44-pin G: 48-pin J: 52-pin L: 64-pin M: 80-pin P: 100-pin RL78/G14 Memory type: F: Flash memory Renesas MCU Renesas semiconductor product



[44-pin, 48-pin, 52-pin, 64-pin products (code flash memory 96 KB to 256 KB)]

Caution This outline describes the functions at the time when Peripheral I/O redirection register 0, 1 (PIOR0, 1) are set to 00H.

	(PIORU, I) are set to				(1/2				
		44-pin	48-pin	52-pin	64-pin				
	Item	R5F104Fx	R5F104Gx	R5F104Jx	R5F104Lx				
		(x = F to H, J)	(x = F to H, J)	(x = F to H, J)	(x = F to H, J)				
Code flash me	emory (KB)	96 to 256	96 to 256	96 to 256	96 to 256				
Data flash me	emory (KB)	8	8	8	8				
RAM (KB)		12 to 24 Note	12 to 24 Note	12 to 24 Note	12 to 24 Note				
Address space	e	1 MB							
Main system clock	High-speed system clock	X1 (crystal/ceramic) os HS (high-speed main) HS (high-speed main) LS (low-speed main) n LV (low-voltage main)	mode: 1 to 20 MHz (V mode: 1 to 16 MHz (V node: 1 to 8 MHz (V	/DD = 2.4 to 5.5 V), DD = 1.8 to 5.5 V),	CLK)				
	High-speed on-chip oscillator clock (fiH)	HS (high-speed main) mode: 1 to 32 MHz (VDD = 2.7 to 5.5 V), HS (high-speed main) mode: 1 to 16 MHz (VDD = 2.4 to 5.5 V), LS (low-speed main) mode: 1 to 8 MHz (VDD = 1.8 to 5.5 V), LV (low-voltage main) mode: 1 to 4 MHz (VDD = 1.6 to 5.5 V),							
Subsystem clo	ock	XT1 (crystal) oscillation	n, external subsystem o	clock input (EXCLKS) 32	2.768 kHz				
Low-speed on	n-chip oscillator clock	15 kHz (TYP.): VDD = 1	.6 to 5.5 V						
General-purpose register		8 bits \times 32 registers (8 bits \times 8 registers \times 4 banks)							
Minimum instr	ruction execution time	0.03125 μs (High-speed on-chip oscillator clock: fiн = 32 MHz operation)							
		$0.05 \mu\text{s}$ (High-speed system clock: f _{MX} = 20 MHz operation)							
		30.5 μs (Subsystem clock: fsuв = 32.768 kHz operation)							
Instruction set	ı	 Data transfer (8/16 bits) Adder and subtractor/logical operation (8/16 bits) Multiplication (8 bits × 8 bits, 16 bits × 16 bits), Division (16 bits ÷ 16 bits, 32 bits ÷ 32 bits) Multiplication and Accumulation (16 bits × 16 bits + 32 bits) Rotate, barrel shift, and bit manipulation (Set, reset, test, and Boolean operation), etc. 							
I/O port	Total	40	44	48	58				
	CMOS I/O	31	34	38	48				
	CMOS input	5	5	5	5				
	CMOS output	—	1	1	1				
	N-ch open-drain I/O (6 V tolerance)	4	4	4	4				
Timer	16-bit timer	8 channels (TAU: 4 channels, Timer RJ: 1 channel, Timer RD: 2 channels, Timer RG: 1 channel)							
	Watchdog timer	1 channel							
	Real-time clock (RTC)	1 channel							
		1 channel							
	12-bit interval timer	Timer outputs: 14 channels							
	12-bit interval timer Timer output								

(Note is listed on the next page.)

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Note	The flash library uses RAM in self-programming and rewriting of the data flash memory.
	The target products and start address of the RAM areas used by the flash library are shown below.
	R5F104xJ (x = F, G, J, L, M, P): Start address F9F00H
	For the RAM areas used by the flash library, see Self RAM list of Flash Self-Programming Library for RL78 Family
	(R20UT2944).



(R20UT2944).

 Note
 The flash library uses RAM in self-programming and rewriting of the data flash memory.

 The target products and start address of the RAM areas used by the flash library are shown below.

 R5F104xL (x = G, L, M, P): Start address F3F00H

 For the RAM areas used by the flash library, see Self RAM list of Flash Self-Programming Library for RL78 Family



Items	Symbol	Condit	ons		MIN.	TYP.	MAX.	Unit
Input leakage cur- rent, high	ILIH1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	VI = EVDDO			1	μΑ	
	ILIH2	P20 to P27, P137, P150 to P156, RESET	VI = VDD				1	μA
	Ілнз	P121 to P124 (X1, X2, EXCLK, XT1, XT2, EXCLKS)	VI = VDD	In input port or external clock input			1	μΑ
				In resonator con- nection			10	μA
Input leakage current, low	ILIL1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	VI = EVSS0				-1	μΑ
	ILIL2	P20 to P27, P137, P150 to P156, RESET	VI = Vss				-1	μA
	ILIL3	P121 to P124 (X1, X2, EXCLK, XT1, XT2, EXCLKS)	VI = VSS	In input port or external clock input			-1	μA
				In resonator con- nection			-10	μA
On-chip pull-up resistance	Ru	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57, P64 to P67, P70 to P77, P80 to P87, P100 to P102, P110, P111, P120, P140 to P147	VI = EVsso	, In input port	10	20	100	kΩ

(TA = -40 to +85°C, 1.6 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(5/5)

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



2.3.2 Supply current characteristics

(1) Flash ROM: 16 to 64 KB of 30- to 64-pin products

Parameter	Symbol			Conditions			MIN.	TYP.	MAX.	Unit
Supply	IDD1	Operat-	HS (high-speed main)	fносо = 64 MHz,	Basic	V _{DD} = 5.0 V		2.4		mA
current		ing mode	mode Note 5	fiH = 32 MHz Note 3	operation	VDD = 3.0 V		2.4		
Note 1				fносо = 32 MHz,	Basic	VDD = 5.0 V		2.1		
				fiH = 32 MHz Note 3	operation	VDD = 3.0 V		2.1		
			HS (high-speed main)	fносо = 64 MHz,	Normal	VDD = 5.0 V		5.1	8.7	mA
			mode Note 5	fiн = 32 MHz Note 3	operation	VDD = 3.0 V		5.1	8.7	
				fносо = 32 MHz,	Normal	VDD = 5.0 V		4.8	8.1	
				fiH = 32 MHz Note 3	operation	VDD = 3.0 V		4.8	8.1	
				fносо = 48 MHz,	Normal	VDD = 5.0 V		4.0	6.9	
				fiH = 24 MHz Note 3	operation	VDD = 3.0 V		4.0	6.9	
				fносо = 24 MHz,	Normal	VDD = 5.0 V		3.8	6.3	
				fiH = 24 MHz Note 3	operation	VDD = 3.0 V		3.8	6.3	
				fносо = 16 MHz,	Normal	VDD = 5.0 V		2.8	4.6	
				fiH = 16 MHz Note 3	operation	VDD = 3.0 V		2.8	4.6	
			LS (low-speed main)	fносо = 8 MHz,	Normal	VDD = 3.0 V		1.3	2.0	mA
			mode Note 5	fiH = 8 MHz Note 3	operation	VDD = 2.0 V		1.3	2.0	
			LV (low-voltage main)	fносо = 4 MHz,	Normal	VDD = 3.0 V		1.3	1.8	mA
			mode Note 5	fiH = 4 MHz Note 3	operation	VDD = 2.0 V		1.3	1.8	
			HS (high-speed main)	, ,	Normal operation	Square wave input		3.3	5.3	mA
			mode Note 5			Resonator connection		3.4	5.5	
				fmx = 20 MHz Note 2,	Normal	Square wave input		3.3	5.3	
				VDD = 3.0 V	operation	Resonator connection		3.4	5.5	
				fmx = 10 MHz Note 2,	Normal	Square wave input		2.0	3.1	
				VDD = 5.0 V	operation	Resonator connection		2.1	3.2	
				fmx = 10 MHz Note 2,	Normal	Square wave input		2.0	3.1	
				VDD = 3.0 V	operation	Resonator connection		2.1	3.2	
			LS (low-speed main)	f _{MX} = 8 MHz Note 2,	Normal	Square wave input		1.2	1.9	mA
			mode Note 5	VDD = 3.0 V	operation	Resonator connection		1.2	2.0	
				fmx = 8 MHz Note 2,	Normal	Square wave input		1.2	1.9	
				VDD = 2.0 V	operation	Resonator connection		1.2	2.0	
			Subsystem clock	fsue = 32.768 kHz Note 4	Normal	Square wave input		4.7	6.1	μA
			operation	TA = -40°C	operation	Resonator connection		4.7	6.1	
				fsue = 32.768 kHz Note 4	Normal	Square wave input		4.7	6.1	
				TA = +25°C	operation	Resonator connection		4.7	6.1	
	ТА	fsue = 32.768 kHz Note 4	Normal	Square wave input		4.8	6.7	1		
		TA = +50°C	operation	Resonator connection	1	4.8	6.7	1		
		fsue = 32.768 kHz Note 4	Normal	Square wave input		4.8	7.5	1		
				TA = +70°C	operation	Resonator connection		4.8	7.5	1
				fsue = 32.768 kHz Note 4	Normal	Square wave input		5.4	8.9	1
				TA = +85°C	operation	Resonator connection		5.4	8.9	1

(Notes and Remarks are listed on the next page.)

(4) Peripheral Functions (Common to all products)

(TA = -40 to +85°C, 1.6 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, Vss = EVss0 = EVss1 = 0 V)

Parameter	Symbol	Condit	ions	MIN.	TYP.	MAX.	Unit
Low-speed on-chip oscilla- tor operating current	I _{FIL} Note 1				0.20		μA
RTC operating current	IRTC Notes 1, 2, 3				0.02		μA
12-bit interval timer operat- ing current	IIT Notes 1, 2, 4				0.02		μA
Watchdog timer operating current	I _{WDT} Notes 1, 2, 5	fı∟ = 15 kHz			0.22		μA
A/D converter operating cur- rent	IADC Notes 1, 6	When conversion at maximum speed	Normal mode, AV _{REFP} = V _{DD} = 5.0 V		1.3	1.7	mA
			Low voltage mode, AV _{REFP} = V _{DD} = 3.0 V		0.5	0.7	mA
A/D converter reference voltage current	IADREF Note 1				75.0		μA
Temperature sensor operat- ing current	ITMPS Note 1				75.0		μA
D/A converter operating cur- rent	IDAC Notes 1, 11, 13	Per D/A converter channel				1.5	mA
Comparator operating cur-	I _{CMP} Notes 1, 12, 13	VDD = 5.0 V,	Window mode		12.5		μA
rent		Regulator output voltage = 2.1 V	Comparator high-speed mode		6.5		μA
			Comparator low-speed mode		1.7		μΑ
		VDD = 5.0 V,	Window mode		8.0		μA
		Regulator output voltage = 1.8 V	Comparator high-speed mode		4.0		μA
			Comparator low-speed mode		1.3		μA
LVD operating current	ILVD Notes 1, 7				0.08		μΑ
Self-programming operat- ing current	IFSP Notes 1, 9				2.50	12.20	mA
BGO operating current	IBGO Notes 1, 8				2.50	12.20	mA
SNOOZE operating current	ISNOZ Note 1	ADC operation	The mode is performed Note 10		0.50	0.60	mA
			The A/D conversion opera- tions are performed, Low volt- age mode, AVREFP = VDD = 3.0 V		1.20	1.44	
		CSI/UART operation			0.70	0.84	
		DTC operation			3.10		

Note 1. Current flowing to VDD.

Note 2. When high speed on-chip oscillator and high-speed system clock are stopped.

Note 3. Current flowing only to the real-time clock (RTC) (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IRTC, when the real-time clock operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added. IDD2 subsystem clock operation includes the operational current of the real-time clock.

Note 4. Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IIT, when the 12-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added.

(2) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)

Parameter	Symbol	Conditions		HS (high-s main) mo		LS (low-sp main) mo		LV (low-vo main) mo	0	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY1	tkcy1 ≥ 2/fclk	$4.0~V \leq EV_{DD0} \leq 5.5~V$	62.5		250		500		ns
			$2.7 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.5 \text{ V}$			250		500		ns
SCKp high-/low-level	tкнı,	$4.0 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.5 \text{ V}$		tксү1/2 - 7		tксү1/2 - 50		tксү1/2 - 50		ns
width	tĸ∟1	$2.7 \text{ V} \leq EV_{\text{DD0}}$	≤ 5.5 V	tксү1/2 - 10		tксү1/2 - 50		tксү1/2 - 50		ns
SIp setup time (to SCKp↑)	tsik1	$4.0 \; V \leq EV_{\text{DD0}}$	≤ 5.5 V	23		110		110		ns
Note 1		$2.7~V \leq EV_{DD0} \leq 5.5~V$		33		110		110		ns
SIp hold time (from SCKp↑) ^{Note 2}	tksi1	$2.7 \text{ V} \leq EV_{DD0} \leq 5.5 \text{ V}$		10		10		10		ns
Delay time from SCKp↓ to SOp output ^{Note 3}	tkso1	C = 20 pF Note	C = 20 pF Note 4		10		10		10	ns

(TA = -40 to +85°C, 2.7 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

Note 2. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp hold time becomes "from SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Note 3. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes "from SCKp↑" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Note 4. C is the load capacitance of the SCKp and SOp output lines.

Caution Select the normal input buffer for the SIp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

Remark 1. This value is valid only when CSI00's peripheral I/O redirect function is not used.

Remark 2. p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0),

g: PIM and POM numbers (g = 1)

Remark 3. fMCK: Serial array unit operation clock frequency (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00))



Note 1. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The SIp setup time becomes "to SCKp↓" when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

Parameter	Symbol	Conditions		speed main) ode		peed main) ode	LV (low-voltage main) mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLr clock frequency	fscL	$\begin{array}{l} 2.7 \ \text{V} \leq E V_{\text{DD0}} \leq 5.5 \ \text{V}, \\ \text{C}_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$		1000 Note 1		400 Note 1		400 Note 1	kHz
		$\label{eq:loss} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} \leq 5.5 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 3 k\Omega \end{array}$		400 Note 1		400 Note 1		400 Note 1	kHz
		$\begin{array}{l} 1.8 \text{ V} \leq EV_{\text{DD0}} < 2.7 \text{ V}, \\ C_{\text{b}} = 100 \text{ pF}, \text{ R}_{\text{b}} = 5 \text{ k}\Omega \end{array}$		300 Note 1		300 Note 1		300 Note 1	kHz
		$\label{eq:bound} \begin{array}{l} 1.7 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$		250 Note 1		250 Note 1		250 Note 1	kHz
		$\label{eq:bound} \begin{array}{l} 1.6 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$		-		250 Note 1		250 Note 1	kHz
Hold time when SCLr = "L"	tLOW	$\begin{array}{l} 2.7 \ \text{V} \leq E V_{\text{DD0}} \leq 5.5 \ \text{V}, \\ \text{C}_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$	475		1150		1150		ns
		$\begin{array}{l} 1.8 \text{ V} \leq EV_{\text{DD0}} \leq 5.5 \text{ V}, \\ \text{C}_{\text{b}} = 100 \text{ pF}, \text{ R}_{\text{b}} = 3 \text{ k}\Omega \end{array}$	1150		1150		1150		ns
		$\label{eq:bound} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} < 2.7 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$	1550		1550		1550		ns
		$\label{eq:bound} \begin{array}{l} 1.7 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$	1850		1850		1850		ns
		$\label{eq:bound} \begin{array}{l} 1.6 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$	—		1850		1850		ns
Hold time when SCLr = "H"	tніgн	$\begin{array}{l} 2.7 \ \text{V} \leq E V_{\text{DD0}} \leq 5.5 \ \text{V}, \\ \text{C}_{\text{b}} = 50 \ \text{pF}, \ \text{R}_{\text{b}} = 2.7 \ \text{k}\Omega \end{array}$	475		1150		1150		ns
		$\begin{array}{l} 1.8 \text{ V} \leq EV_{\text{DD0}} \leq 5.5 \text{ V}, \\ \text{C}_{\text{b}} = 100 \text{ pF}, \text{ R}_{\text{b}} = 3 \text{ k}\Omega \end{array}$	1150		1150		1150		ns
		$\label{eq:loss} \begin{array}{l} 1.8 \mbox{ V} \leq EV_{\mbox{DD0}} < 2.7 \mbox{ V}, \\ C_{\mbox{b}} \mbox{=} 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} \mbox{=} 5 \mbox{ k}\Omega \end{array}$	1550		1550		1550		ns
		$\label{eq:bound} \begin{array}{l} 1.7 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$	1850		1850		1850		ns
		$\label{eq:linear} \begin{array}{l} 1.6 \mbox{ V} \leq EV_{\mbox{DD0}} < 1.8 \mbox{ V}, \\ C_{\mbox{b}} = 100 \mbox{ pF}, \mbox{ R}_{\mbox{b}} = 5 k\Omega \end{array}$	_		1850		1850		ns

(5) During communication at same potential (simplified I²C mode)

(TA = -40 to +85°C, 1.6 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(Notes and Caution are listed on the next page, and Remarks are listed on the page after the next page.)



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(7) Communication at different potential (2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)

Parameter	Symbol		Conditions	HS (high-s main) mo		LS (low-speed mode	,	LV (low-vo main) mo	•	Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tксү1	tксү1 ≥ 2/fс∟к	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \leq 5.5 \; V, \\ 2.7 \; V \leq V_b \leq 4.0 \; V, \\ C_b = 20 \; pF, \; R_b = 1.4 \; k\Omega \end{array}$	200		1150		1150		ns
			$\begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 20 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$	300		1150		1150		ns
SCKp high-level width	tкнı	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \\ 2.7 \; V \leq V_{b} \leq 2 \\ C_{b} = 20 \; pF, \; R_{b} \end{array}$	4.0 V,	tксү1/2 - 50		tксү1/2 - 50		tксү1/2 - 50		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} \\ 2.3 \ V \leq V_{b} \leq 2 \\ C_{b} \texttt{=} 20 \ pF, \ R_{b} \end{array}$	2.7 V,	tксү1/2 - 120		tксү1/2 - 120		tксү1/2 - 120	y1/2 - 120	
SCKp low-level width	tĸ∟1	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \\ 2.7 \; V \leq V_{b} \leq \\ C_{b} \texttt{=} 20 \; pF, \; R_{b} \end{array}$	4.0 V,	tксү1/2 - 7		tксү1/2 - 50		tксү1/2 - 50		ns
				ns						
SIp setup time (to SCKp↑) ^{Note 1}	tsik1	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \\ 2.7 \; V \leq V_{b} \leq \\ C_{b} = 20 \; pF, \; R_{b} \end{array}$	4.0 V,	58		479		479		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} \\ 2.3 \ V \leq V_{b} \leq \\ C_{b} \texttt{=} 20 \ pF, \ R_{b} \end{array}$	2.7 V,	121		479		479		ns
SIp hold time (from SCKp↑) ^{Note 1}	tksi1	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \\ 2.7 \; V \leq V_{b} \leq \\ C_{b} = 20 \; pF, \; R_{b} \end{array}$	4.0 V,	10		10		10		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} \\ 2.3 \ V \leq V_{b} \leq \\ C_{b} \texttt{=} 20 \ pF, \ R_{b} \end{array}$	2.7 V,	10		10		10		ns
Delay time from SCKp↓ to SOp out- put ^{Note 1}	tkso1	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \\ 2.7 \; V \leq V_{b} \leq \\ C_{b} = 20 \; pF, \; R_{b} \end{array}$	4.0 V,		60		60		60	ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} \\ 2.3 \ V \leq V_{b} \leq \\ C_{b} \texttt{=} 20 \ pF, \ R_{b} \end{array}$	2.7 V,		130		130		130	ns

(TA = -40 to +85°C, 2.7 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

(Notes, Caution, and Remarks are listed on the next page.)



(2/3)

(8) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output)

Parameter	Symbol	Conditions		speed main) ode	•	peed main) ode		oltage main) ode	Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SIp setup time (to SCKp↑) ^{Note 1}	tsıĸı		81		479		479		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} < 4.0 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$	177		479		479		ns
		$\begin{array}{l} 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V \ \text{Note 2}, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$	479		479		479		ns
SIp hold time (from SCKp↑) ^{Note 1}	tksi1		19		19		19		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} < 4.0 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$	19		19		19		ns
		$ \begin{split} & 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ & 1.6 \ V \leq V_b \leq 2.0 \ V \ ^{Note \ 2}, \\ & C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{split} $	19		19		19		ns
Delay time from SCKp↓ to SOp output ^{Note 1}	tkso1			100		100		100	ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD0} < 4.0 \ V, \\ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$		195		195		195	ns
		$ \begin{split} & 1.8 \ V \leq EV_{DD0} < 3.3 \ V, \\ & 1.6 \ V \leq V_b \leq 2.0 \ V \ ^{Note \ 2}, \\ & C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{split} $		483		483		483	ns

(TA = -40 to +85°C, 1.8 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, Vss = EVss0 = EVss1 = 0 V)

Note 1. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.

Note 2. Use it with $EV_{DD0} \ge V_b$.

(Remarks are listed on the page after the next page.)



Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (VDD tolerance (for the 30- to 52-pin products)/EVDD tolerance (for the 64- to 100-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

3. ELECTRICAL SPECIFICATIONS (G: INDUSTRIAL APPLICATIONS TA = -40 to +105°C)

This chapter describes the following electrical specifications. Target products G: Industrial applications $T_A = -40$ to $+105^{\circ}C$ R5F104xxGxx

- Caution 1. The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.
- Caution 2. With products not provided with an EVDD0, EVDD1, EVSS0, or EVSS1 pin, replace EVDD0 and EVDD1 with VDD, or replace EVSS0 and EVSS1 with VSS.
- Caution 3. The pins mounted depend on the product. Refer to 2.1 Port Functions to 2.2.1 Functions for each product in the RL78/G14 User's Manual.
- Caution 4. Please contact Renesas Electronics sales office for derating of operation under TA = +85 to +105°C. Derating is the systematic reduction of load for the sake of improved reliability.
- Remark When RL78/G14 is used in the range of T_A = -40 to +85°C, see 2. ELECTRICAL SPECIFICATIONS (T_A = -40 to +85°C).



Itomo	Cumbel			MINI	MAX	1.1.0.14	
Items	Symbol	Conditior	-	MIN.	TYP.	MAX.	Unit
Output voltage, high	VOH1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57,	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOH1 = -3.0 mA	EVDD0 - 0.7			V
		P80 to P87, P100 to P102, P110, P111, P120, P130, P140 to P147	2.7 V ≤ EVDD0 ≤ 5.5 V, Іон1 = -2.0 mA	EVDD0 - 0.6			V
			2.4 V ≤ EVDD0 ≤ 5.5 V, Іон1 = -1.5 mA	EVDD0 - 0.5			V
	Voh2	P20 to P27, P150 to P156	2.4 V ≤ Vdd ≤ 5.5 V, Ioh2 = -100 μA	Vdd - 0.5			V
Output voltage, low	VOL1	P00 to P06, P10 to P17, P30, P31, P40 to P47, P50 to P57,	$\begin{array}{l} 4.0 \ V \leq EV_{DD0} \leq 5.5 \ V, \\ I_{OL1} = 8.5 \ mA \end{array}$			0.7	V
		P80 to P87, P100 to P102, P110, P111, P120, P130	$2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL1 = 3.0 mA			0.6	V
			$2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL1 = 1.5 mA			0.4	V
			$2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL1 = 0.6 mA		0.4	V	
	Vol2	P20 to P27, P150 to P156	$\begin{array}{l} \text{2.4 V} \leq \text{Vdd} \leq 5.5 \text{ V},\\ \text{Iol2 = 400 } \mu\text{A} \end{array}$			0.4	V
	Vol3 P60 to P63	P60 to P63	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL3 = 15.0 mA			2.0	V
			$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL3 = 5.0 mA		0.4	V	
			$2.7 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ IOL3 = 3.0 mA			0.4	V
		$2.4 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V},$ lol3 = 2.0 mA			0.4	V	

(TA = -40 to +105°C, 2.4 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 = 0 V)

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Caution P00, P02 to P04, P10, P11, P13 to P15, P17, P30, P43 to P45, P50 to P55, P71, P74, P80 to P82, P142 to P144 do not output high level in N-ch open-drain mode.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



		0, 214 1 21		$DD \le 5.5 \text{ V}, \text{ Vss} = \text{EVs}$	==============				(2/2
Parameter	Symbol			Conditions		MIN.	TYP.	MAX.	Uni
Supply cur- ent ^{Note 1}	IDD2 Note 2	HALT mode	HS (high-speed main) mode Note 7	fносо = 64 MHz, fiн = 32 MHz ^{Note 4}	$V_{DD} = 5.0 V$		0.79	4.86	mA
SIIC			mode		V _{DD} = 3.0 V		0.79	4.86	-
				fносо = 32 MHz, fн = 32 MHz ^{Note 4}	VDD = 5.0 V		0.49	4.17	-
					V _{DD} = 3.0 V		0.49	4.17	-
				fносо = 48 MHz, fн = 24 MHz ^{Note 4}	VDD = 5.0 V		0.62	3.82	-
					V _{DD} = 3.0 V		0.62	3.82	-
				fносо = 24 MHz, fн = 24 MHz ^{Note 4}	VDD = 5.0 V		0.4	3.25	-
					VDD = 3.0 V		0.4	3.25	-
				fносо = 16 MHz, fн = 16 MHz ^{Note 4}	VDD = 5.0 V		0.38	2.28	-
					VDD = 3.0 V		0.38	2.28	<u> </u>
			HS (high-speed main) mode Note 7	$f_{MX} = 20 \text{ MHz} \text{ Note 3},$	Square wave input		0.30	2.65	m/
			mode note /	VDD = 5.0 V	Resonator connection		0.40	2.77	_
				$f_{MX} = 20 \text{ MHz} \text{ Note } 3,$	Square wave input		0.30	2.65	_
				VDD = 3.0 V	Resonator connection		0.40	2.77	_
				$f_{MX} = 10 \text{ MHz} \text{ Note 3},$	Square wave input		0.20	1.36	_
				VDD = 5.0 V	Resonator connection		0.25	1.46	
f _{MX} = 10 MH V _{DD} = 3.0 V	$f_{MX} = 10 \text{ MHz} \text{ Note 3},$	Square wave input		0.20	1.36				
				VDD = 3.0 V	Resonator connection		0.25	1.46	
			Subsystem clock oper-	fsue = 32.768 kHz Note 5,	Square wave input		0.28	0.66	μ/
			ation	TA = -40°C	Resonator connection		0.47	0.85	
				fsue = 32.768 kHz Note 5,	Square wave input		0.34	0.66	
				TA = +25°C	Resonator connection		0.53	0.85	
				fsue = 32.768 kHz ^{Note 5} ,	Square wave input		0.37	2.35	
				TA = +50°C	Resonator connection		0.56	2.54	
				fsue = 32.768 kHz Note 5,	Square wave input		0.61	4.08	
				TA = +70°C	Resonator connection		0.80	4.27	1
				fsue = 32.768 kHz Note 5,	Square wave input		1.55	8.09	1
				TA = +85°C	Resonator connection		1.74	8.28	1
				fsue = 32.768 kHz Note 5,	Square wave input		6.00	51.00	1
				TA = +105°C	Resonator connection		6.00	51.00	1
	Idd3	STOP mode	TA = -40°C				0.19	0.57	μ/
	Note 6	Note 8	TA = +25°C				0.25	0.57	1
			TA = +50°C				0.33	2.26	
			TA = +70°C				0.52	3.99	1
			TA = +85°C				1.46	8.00	1
			T _A = +105°C				5.50	50.00	1

(2) Flash ROM: 96 to 256 KB of 30- to 100-pin products

(Notes and Remarks are listed on the next page.)

(7) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (slave mode, SCKp... external clock input)

1	$x = -40$ to +105°C, 2.4 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, Vss = EVss0 = EVss1 = 0	0 V)
	$(-40 10 + 103 C, 2.4 V \le LVDD0 - LVDD1 \le VDD \le 3.3 V, V33 - LV330 - LV331 - 0$	J V J

Parameter	Symbol	Cor	nditions	HS (high-spee	ed main) mode	Unit
				MIN.	MAX.	
SCKp cycle time Note 1	tксү2	$4.0~V \leq EV_{DD0} \leq 5.5~V,$	24 MHz < fмск	28/f мск		ns
		$2.7~V \leq V_b \leq 4.0~V$	$20 \text{ MHz} < f_{\text{MCK}} \leq 24 \text{ MHz}$	24/fмск		ns
			$8 \text{ MHz} < \text{fmck} \le 20 \text{ MHz}$	20/fмск		ns
			$4 \text{ MHz} < f_{\text{MCK}} \le 8 \text{ MHz}$	16/fмск		ns
			fмск ≤ 4 MHz	12/fмск		ns
		$2.7 \text{ V} \leq EV_{\text{DD0}} < 4.0 \text{ V},$	24 MHz < fмск	40/fмск		ns
		$2.3~V \leq V_b \leq 2.7~V$	$20 \text{ MHz} < f_{MCK} \leq 24 \text{ MHz}$	32/fмск		ns
			$16 \text{ MHz} < f_{\text{MCK}} \le 20 \text{ MHz}$	28/fмск		ns
			8 MHz < fмck ≤ 16 MHz	24/fмск		ns
				16/fмск		ns
			fмск ≤ 4 MHz	12/fмск		ns
		$2.4~V \leq EV_{\text{DD0}} < 3.3~V,$	24 MHz < fмск	96/fмск		ns
		$1.6~V \leq V_b \leq 2.0~V$	$20 \text{ MHz} < f_{MCK} \leq 24 \text{ MHz}$	72/fмск		ns
			$16 \text{ MHz} < f_{\text{MCK}} \le 20 \text{ MHz}$	64/fмск		ns
			$8 \text{ MHz} < \text{fmck} \le 16 \text{ MHz}$	52/f мск		ns
			$4 \text{ MHz} < \text{fmck} \le 8 \text{ MHz}$	32/fмск		ns
			fмск ≤ 4 MHz	20/fмск		ns
SCKp high-/low-level	tĸн₂, tĸ∟₂	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V}, 2.$	$4.0 \text{ V} \leq \text{EV}_{\text{DD0}} \leq 5.5 \text{ V}, 2.7 \text{ V} \leq \text{V}_{\text{b}} \leq 4.0 \text{ V}$			ns
width		$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V}, 2.10 \text{ V}$	$2.7 \; V \leq EV_{DD0} < 4.0 \; V, 2.3 \; V \leq V_b \leq 2.7 \; V$			ns
		$2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V}, 1.$	$6 \text{ V} \leq \text{V}_b \leq 2.0 \text{ V}$	tксү2/2 - 100		ns
SIp setup time	tsik2	$4.0 \text{ V} \le \text{EV}_{\text{DD0}} \le 5.5 \text{ V}, 2.$	$7~V \le V_b \le 4.0~V$	1/fмск + 40		ns
(to SCKp↑) Note 2		$2.7 \text{ V} \le \text{EV}_{\text{DD0}} < 4.0 \text{ V}, 2.10 \text{ V}$	$3 \text{ V} \leq \text{V}_b \leq 2.7 \text{ V}$	1/fмск + 40		ns
		$2.4 \text{ V} \le \text{EV}_{\text{DD0}} < 3.3 \text{ V}, 1.$	$6 \text{ V} \leq \text{V}_b \leq 2.0 \text{ V}$	1/fмск + 60		ns
SIp hold time (from SCKp↑) ^{Note 3}	tksi2			1/fмск + 62		ns
Delay time from SCKp↓ to SOp output ^{Note 4}	tkso2	$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \leq 5.5 \; V, \; 2. \\ C_b = 30 \; pF, \; R_b = 1.4 \; k\Omega \end{array}$	$7 \text{ V} \leq V_b \leq 4.0 \text{ V},$		2/fмск + 240	ns
		$\label{eq:2.7} \begin{array}{l} 2.7 \ V \leq EV_{DD0} < 4.0 \ V, \ 2. \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$	$3~V \leq V_b \leq 2.7~V,$		2/fмск + 428	ns
		$2.4 \text{ V} \leq \text{EV}_{\text{DD0}} < 3.3 \text{ V}, 1.$ Cb = 30 pF, Rv = 5.5 k Ω	$6 \text{ V} \leq \text{V}_b \leq 2.0 \text{ V},$		2/fмск + 1146	ns

(Notes, Caution, and Remarks are listed on the next page.)



(8) Communication at different potential (1.8 V, 2.5 V, 3 V) (simplified I²C mode)

(TA = -40 to +105°C, 2.4 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, VSS = EVSS0 = EVSS1 =	0 V)
	· • • ,

(1/2)

Parameter	Symbol	Conditions	HS (high-spe	ed main) mode	Unit
			MIN.	MAX.	
SCLr clock frequency	fsc∟			400 Note 1	kHz
		$\begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 50 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$		400 Note 1	kHz
				100 Note 1	kHz
		$\begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$		100 Note 1	kHz
		$\begin{array}{l} 2.4 \; V \leq EV_{DD0} < 3.3 \; V, \\ 1.6 \; V \leq V_b \leq 2.0 \; V, \\ C_b = 100 \; pF, \; R_b = 5.5 \; k\Omega \end{array}$		100 Note 1	kHz
lold time when SCLr = "L"	tLOW		1200		ns
		$\begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 50 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$	1200		ns
			4600		ns
		$\label{eq:2.7} \begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 100 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$	4600		ns
		$\label{eq:2.4} \begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 100 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$	4650		ns
Hold time when SCLr = "H"	tніgн		620		ns
		$\begin{array}{l} 2.7 \; V \leq EV_{DD0} < 4.0 \; V, \\ 2.3 \; V \leq V_b \leq 2.7 \; V, \\ C_b = 50 \; pF, \; R_b = 2.7 \; k\Omega \end{array}$	500		ns
		$\begin{array}{l} 4.0 \; V \leq EV_{DD0} \leq 5.5 \; V, \\ 2.7 \; V \leq V_b \leq 4.0 \; V, \\ C_b = 100 \; pF, \; R_b = 2.8 \; k\Omega \end{array}$	2700		ns
		$\label{eq:VDD} \begin{split} 2.7 \ V &\leq EV_{DD0} < 4.0 \ V, \\ 2.3 \ V &\leq V_b \leq 2.7 \ V, \\ C_b &= 100 \ pF, \ R_b = 2.7 \ k\Omega \end{split}$	2400		ns
		$\label{eq:2.4} \begin{array}{l} 2.4 \ V \leq EV_{DD0} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 100 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$	1830		ns



(2) When reference voltage (+) = AVREFP/ANIO (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target pin: ANI16 to ANI20

Parameter	Symbol	Cond	litions	MIN.	TYP.	MAX.	Unit	
Resolution	RES			8		10	bit	
Overall error Note 1	AINL	10-bit resolution EVDD0 ≤ AVREFP = VDD Notes 3, 4	$2.4~V \leq AV_{REFP} \leq 5.5~V$		1.2	±5.0	LSB	
Conversion time	tconv	10-bit resolution	$3.6~V \le V_{DD} \le 5.5~V$	2.125		39	μs	
		Target ANI pin: ANI16 to ANI20	$2.7~V \leq V_{DD} \leq 5.5~V$	3.1875		39	μs	
			$2.4~\text{V} \leq \text{V}_{\text{DD}} \leq 5.5~\text{V}$	17		39	μs	
Zero-scale error Notes 1, 2	Ezs	10-bit resolution EVDD0 ≤ AVREFP = VDD Notes 3, 4	$2.4~V \leq AV_{REFP} \leq 5.5~V$			±0.35	%FSR	
Full-scale error Notes 1, 2	Efs	10-bit resolution EVDD0 ≤ AVREFP = VDD Notes 3, 4	$2.4~V \leq AV_{REFP} \leq 5.5~V$			±0.35	%FSR	
Integral linearity error Note 1	ILE	10-bit resolution EVDD0 ≤ AVREFP = VDD Notes 3, 4	$2.4~V \leq AV_{REFP} \leq 5.5~V$			±3.5	LSB	
Differential linearity error Note 1	DLE	10-bit resolution EVDD0 ≤ AVREFP = VDD Notes 3, 4	$2.4~V \leq AV_{REFP} \leq 5.5~V$			±2.0	LSB	
Analog input voltage	VAIN	ANI16 to ANI20	•	0		AVREFP and EVDD0	V	

(TA = -40 to +105°C, 2.4 V \leq EVDD0 = EVDD1 \leq VDD \leq 5.5 V, 2.4 V \leq AVREFP \leq VDD \leq 5.5 V, Vss = EVsso = EVss1 = 0 V, Reference voltage (+) = AVREFP, Reference voltage (-) = AVREFM = 0 V)

Note 1. Excludes quantization error (±1/2 LSB).

Note 2. This value is indicated as a ratio (%FSR) to the full-scale value.

Note 3. When $EVDD0 \le AVREFP \le VDD$, the MAX. values are as follows.

	Overall error:	Add ± 1.0 LSB to the MAX. value when AVREFP = VDD.
	Zero-scale error/Full-scale error:	Add $\pm 0.05\%$ FSR to the MAX. value when AVREFP = VDD.
	Integral linearity error/ Differential linearity error:	Add ±0.5 LSB to the MAX. value when AVREFP = VDD.
Note 4.	When AVREFP < EVDD0 \leq VDD, the MAX. values a	are as follows.
	Overall error:	Add ±4.0 LSB to the MAX. value when AVREFP = VDD.

Zero-scale error/Full-scale error:

Add ±0.20%FSR to the MAX. value when AVREFP = VDD. Integral linearity error/ Differential linearity error: Add ±2.0 LSB to the MAX. value when AVREFP = VDD.



3.6.2 Temperature sensor characteristics/internal reference voltage characteristic

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Temperature sensor output voltage	VTMPS25	Setting ADS register = 80H, T _A = +25°C		1.05		V
Internal reference voltage	Vbgr	Setting ADS register = 81H	1.38	1.45	1.5	V
Temperature coefficient	FVTMPS	Temperature sensor that depends on the temperature		-3.6		mV/°C
Operation stabilization wait time	tamp		5			μs

(TA = -40 to +105°C, 2.4 V \leq VDD \leq 5.5 V, Vss = EVsso = EVss1 = 0 V, HS (high-speed main) mode)

3.6.3 D/A converter characteristics

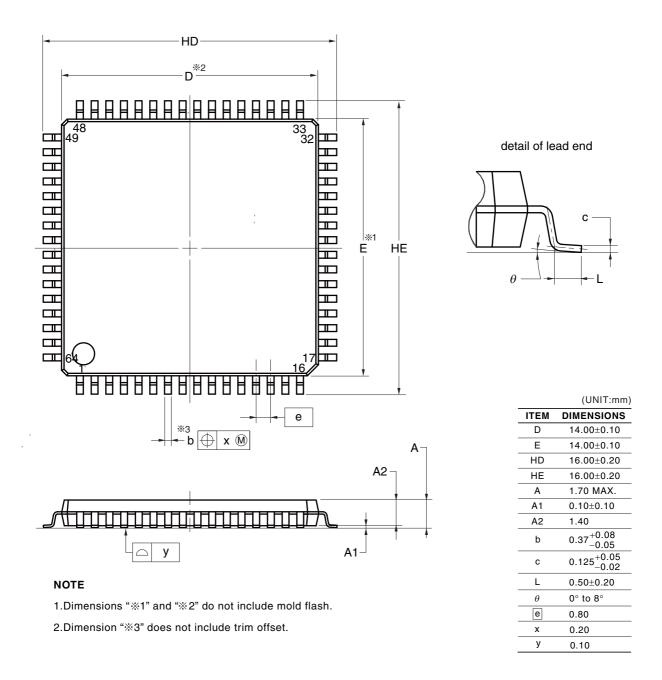
(TA = -40 to +105°C, 2.4 V \leq EVsso = EVss1 \leq VDD \leq 5.5 V, Vss = EVsso = EVss1 = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES					8	bit
Overall error	AINL	Rload = 4 M Ω	$2.4~V \leq V_{DD} \leq 5.5~V$			±2.5	LSB
		Rload = 8 MΩ	$2.4~V \leq V \text{DD} \leq 5.5~V$			±2.5	LSB
Settling time	tset	Cload = 20 pF	$2.7~V \leq V\text{DD} \leq 5.5~V$			3	μs
			$2.4~V \leq V_{DD} < 2.7~V$			6	μs



R5F104LCAFP, R5F104LDAFP, R5F104LEAFP, R5F104LFAFP, R5F104LGAFP, R5F104LHAFP, R5F104LJAFP R5F104LCDFP, R5F104LDDFP, R5F104LEDFP, R5F104LFDFP, R5F104LGDFP, R5F104LHDFP, R5F104LJDFP R5F104LCGFP, R5F104LDGFP, R5F104LEGFP, R5F104LFGFP, R5F104LGGFP, R5F104LHGFP, R5F104LJGFP

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LQFP64-14x14-0.80	PLQP0064GA-A	P64GC-80-GBW-1	0.7



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